MOSFET – Power, Single, N-Channel, DPAK/IPAK 30 V, 88 A

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- NVD Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

Applications

- CPU Power Delivery
- DC-DC Converters
- Low Side Switching

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Param	Symbol	Value	Unit		
Drain-to-Source Voltag	V _{DSS}	30	V		
Gate-to-Source Voltage	e		V _{GS}	±20	V
Continuous Drain		T _A = 25°C	I _D	17.4	А
Current (R _{θJA}) (Note 1)		$T_A = 85^{\circ}C$		13.5	
Power Dissipation $(R_{\theta JA})$ (Note 1)		$T_A = 25^{\circ}C$	P _D	2.65	W
Continuous Drain		T _A = 25°C	Ι _D	12.7	А
Current ($R_{\theta JA}$) (Note 2)	Steady	$T_A = 85^{\circ}C$		9.8	
Power Dissipation $(R_{\theta JA})$ (Note 2)	State	$T_A = 25^{\circ}C$	P _D	1.41	W
Continuous Drain		$T_{C} = 25^{\circ}C$	Ι _D	95	А
Current (R _{θJC}) (Note 1)		$T_C = 85^{\circ}C$		73	
Power Dissipation $(R_{\theta JC})$ (Note 1)		T _C = 25°C	P _D	79	w
Pulsed Drain Current	t _p =10μs	T _A = 25°C	I _{DM}	175	А
Current Limited by Packa	age	T _A = 25°C	I _{DmaxPkg}	45	А
Operating Junction and	Storage Te	emperature	T _J , T _{stg}	–55 to 175	°C
Source Current (Body Di	iode)		I _S	55	А
Source Current (Body Di	iode) Pulse	ed t _p =20 μs	I _{SM}	175	А
Drain to Source dV/dt	Drain to Source dV/dt			6.0	V/ns
$ Single Pulse Drain-to-Source Avalanche \\ Energy (V_{DD} = 24 V, V_{GS} = 10 V, \\ L = 1.0 \text{ mH}, \text{ I}_{L(pk)} = 24 \text{ A}, \text{ R}_{G} = 25 \Omega) $			E _{AS}	288	mJ
Lead Temperature for So (1/8" from case for 10 s)	Idering Pu	rposes	ΤL	260	°C

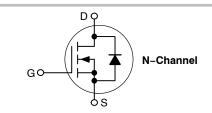
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

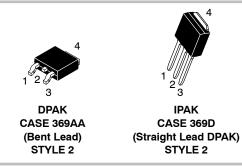


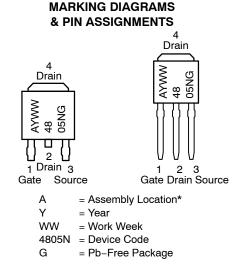
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V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX
30 V	5.0 m Ω @ 10 V	88 A
50 V	7.4 mΩ @ 4.5 V	00 A







* The Assembly Location code (A) is front side optional. In cases where the Assembly Location is stamped in the package, the front side assembly code may be blank.

ORDERING INFORMATION

See detailed ordering and shipping information on page 6 of this data sheet.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{\theta JC}$	1.9	°C/W
Junction-to-TAB (Drain)	$R_{\theta JC-TAB}$	3.5	
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	56.6	
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	106.6	

Surface-mounted on FR4 board using 1 in sq pad size, 1 oz Cu.
 Surface-mounted on FR4 board using the minimum recommended pad size.

ELECTRICAL CHARACTERISTICS (T_J = $25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS					-	-	-
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0 V, I	_D = 250 μA	30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				27		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V,	$T_J = 25^{\circ}C$			1.0	μA
		V _{DS} = 24 V	T _J = 125°C			10	
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V	_{GS} = ±20 V			±100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V _{GS(TH)}	V_{GS} = V_{DS} , I_D = 250 μ A		1.5		2.5	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				5.86		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	$V_{GS} = 10$ to	I _D = 30 A		4.3	5.0	mΩ

	03(01)		·D			
		11.5 V	l _D = 15 A	4.2		
		V _{GS} = 4.5 V	I _D = 30 A	6.0	7.4	
			I _D = 15 A	5.8		
Forward Transconductance	9 _{FS}	V _{DS} = 15 V,	l _D = 15 A	17		S

CHARGES AND CAPACITANCES

Input Capacitance	C _{iss}		2865		pF
Output Capacitance	C _{oss}	V _{GS} = 0 V, f = 1.0 MHz, V _{DS} = 12 V	610		
Reverse Transfer Capacitance	C _{rss}		338		
Total Gate Charge	Q _{G(TOT)}		20.5	26	nC
Threshold Gate Charge	Q _{G(TH)}	V _{GS} = 4.5 V, V _{DS} = 15 V,	4.05		
Gate-to-Source Charge	Q _{GS}	I _D = 30 A	8.28		
Gate-to-Drain Charge	Q _{GD}		8.36		
Total Gate Charge	Q _{G(TOT)}	V_{GS} = 11.5 V, V_{DS} = 15 V, I _D = 30 A	48		nC

SWITCHING CHARACTERISTICS (Note 4)

Turn-On Delay Time	t _{d(on)}		17.2	ns
Rise Time	t _r	V _{GS} = 4.5 V, V _{DS} = 15 V,	20.3	
Turn-Off Delay Time	t _{d(off)}	I_D = 15 A, R_G = 3.0 Ω	20.8	
Fall Time	t _f		8.0	
Turn-On Delay Time	t _{d(on)}		10.8	ns
Rise Time	t _r	V _{GS} = 11.5 V, V _{DS} = 15 V,	20.5	
Turn-Off Delay Time	t _{d(off)}	I_D = 15 A, R_G = 3.0 Ω	30.8	
Fall Time	t _f		4.4	

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted) (continued)

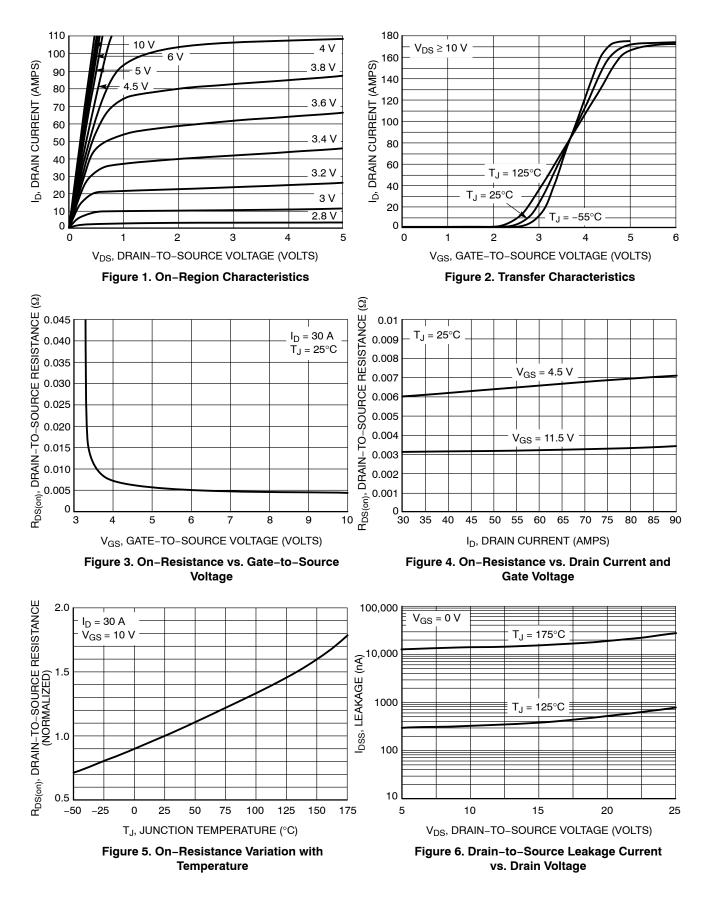
Symbol	Test Condition		Min	Тур	Max	Unit
TICS						
V _{SD}	V_{SD} $V_{GS} = 0 V$, $T_J = 25^{\circ}C$			0.87	1.2	V
	I _S = 30 A	T _J = 125°C		0.76		
t _{RR}				25.7		ns
ta	V _{GS} = 0 V, dls/	dt = 100 A/μs,		13.1		
tb	I _S = 30 A			12.6		
Q _{RR}				18		nC
	TICS V _{SD} t _{RR} ta tb	V _{SD} V _{GS} = 0 V, I _S = 30 A t_{RR} $v_{GS} = 0 V, dIs/I_S = 0 V, dIs/I_S$	$\begin{tabular}{ c c c c c c c c c c c c c c c c c c c$	$\begin{tabular}{ c c c c c c c c c c c c c c c c c c c$	$\begin{tabular}{ c c c c c c c c c c c c c c c c c c c$	$\begin{tabular}{ c c c c c c c c c c c c c c c c c c c$

Source Inductance	L _S		2.49	nH
Drain Inductance, DPAK	L _D		0.0164	
Drain Inductance, IPAK	L _D	$T_A = 25^{\circ}C$	1.88	
Gate Inductance	L _G		3.46	
Gate Resistance	R _G		0.8	Ω

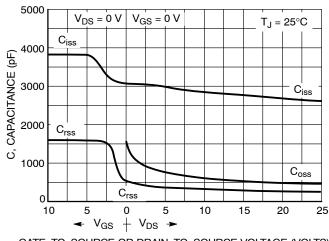
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 3. Pulse Test: Pulse Width \leq 300 µs, Duty Cycle \leq 2%.

4. Switching characteristics are independent of operating junction temperatures.

TYPICAL PERFORMANCE CURVES



TYPICAL PERFORMANCE CURVES







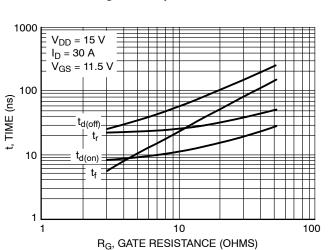


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

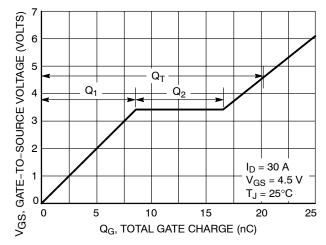


Figure 8. Gate-To-Source and Drain-To-Source Voltage vs. Total Charge

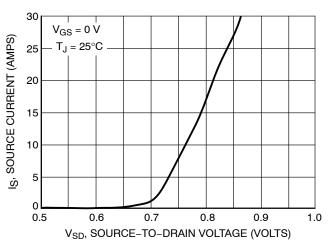
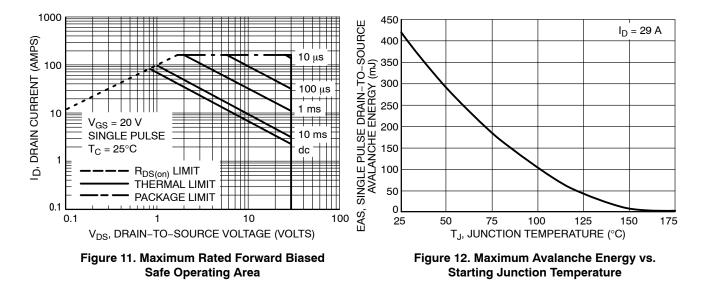


Figure 10. Diode Forward Voltage vs. Current



TYPICAL PERFORMANCE CURVES

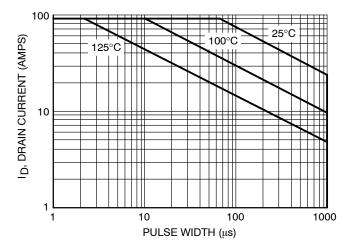
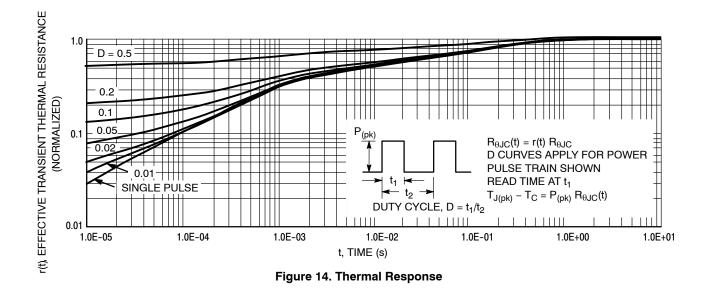


Figure 13. Avalanche Characteristics



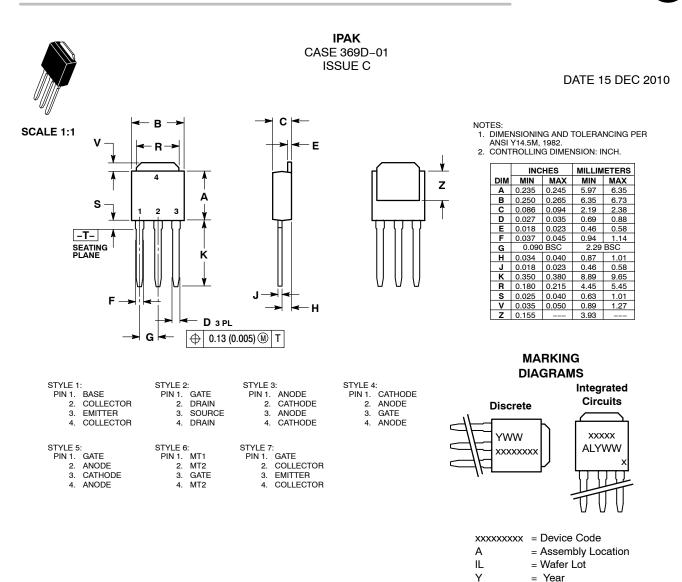
ORDERING INFORMATION

Order Number	Package	Shipping [†]
NTD4805NT4G	DPAK (Pb-Free)	2,500 / Tape & Reel
NTD4805N-1G	IPAK (Pb-Free)	75 Units / Rail
NVD4805NT4G*	DPAK (Pb-Free)	2,500 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

*NVD Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable.

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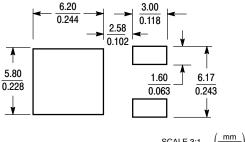
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*For additional information on our Pb-Free strategy and soldering

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details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

DATE 03 JUN 2010

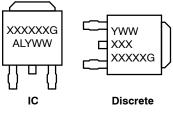
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- 2. CONTROLLING DIMENSION: INCHES. 3. THERMAL PAD CONTOUR OPTIONAL WITHIN DI-
- THERMAL FAD CONTOR OF FIGURE WITHIN DEMONSIONS b3, L3 and Z.
 DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL
- NOT EXCEED 0.006 INCHES PER SIDE 5. DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 6. DATUMS A AND B ARE DETERMINED AT DATUM

	INC	HES	MILLIM	ETERS
DIM	MIN	MAX	MIN	MAX
Α	0.086	0.094	2.18	2.38
A1	0.000	0.005	0.00	0.13
q	0.025	0.035	0.63	0.89
b2	0.030	0.045	0.76	1.14
b3	0.180	0.215	4.57	5.46
c	0.018	0.024	0.46	0.61
c2	0.018	0.024	0.46	0.61
D	0.235	0.245	5.97	6.22
Е	0.250	0.265	6.35	6.73
е	0.090	BSC	2.29	BSC
Н	0.370	0.410	9.40	10.41
L	0.055	0.070	1.40	1.78
L1	0.108	REF	2.74	REF
L2	0.020	BSC	0.51	BSC
L3	0.035	0.050	0.89	1.27
L4		0.040		1.01
Ζ	0.155		3.93	

MARKING DIAGRAM*



= Device Code = Assembly Location L = Wafer Lot Y = Year = Work Week WW G = Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking.

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